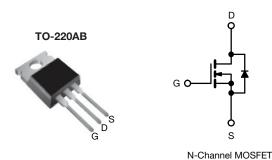


Configuration

Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	60				
$R_{DS(on)}(\Omega)$	$V_{GS} = 5.0 \text{ V}$	0.20			
Q _g (Max.) (nC)	8.4				
Q _{gs} (nC)	3.5				
Q _{gd} (nC)	6.0				

Single

FEATURES

- Dynamic dV/dt rating
- · Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- 175 °C operating temperature
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRLZ14PbF			
Lead (Pb)-free and halogen-free	IRLZ14PbF-BE3			

ABSOLUTE MAXIMUM RATINGS (T_{C}	= 25 °C, un	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	60		
Gate-source voltage			V_{GS}	± 10	V	
Continuous drain current	V _{GS} at 5 V	T _C = 25 °C	- I _D	10		
		T _C = 100 °C		7.2	Α	
Pulsed drain current ^a			I _{DM}	40	1	
Linear derating factor				0.29	W/°C	
Single pulse avalanche energy b			E _{AS}	39.5	mJ	
Maximum power dissipation	T _C =	25 °C	P_{D}	43	W	
Peak diode recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) ^d	For 10 s		-	300 ^d]	
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 0.79 mH, R_g = 25 Ω , I_{AS} = 10 A (see fig. 12)
- c. $I_{SD} \le 10$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	-	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	-	3.5		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-source breakdown voltage	V _{DS}	V _{GS} =	60	-	-	V		
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.070		V/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1.0	-	2.0	V	
Gate-source leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA	
Zero gate voltage drain current	1	V _{DS} = 60 V, V _{GS} = 0 V		-	-	25		
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 48 \text{ V},$, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA	
Drain aguras en etata registance	В	V _{GS} = 5.0 V	I _D = 6.0 A ^b	-	-	0.20		
Drain-source on-state resistance	R _{DS(on)}	$V_{GS} = 4.0 \text{ V}$	$I_D = 5.0 \text{ A}^b$	-	-	0.28	Ω	
Forward transconductance	9 _{fs}	$V_{DS} = 25 \text{ V}, I_D = 6.0 \text{ A}^{b}$		3.5	-	-	S	
Dynamic								
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	400	-	pF	
Output capacitance	C _{oss}			-	170	-		
Reverse transfer capacitance	C _{rss}			-	42	-		
Total gate charge	Qg			-	-	8.4		
Gate-source charge	Q _{gs}	$V_{GS} = 5.0 \text{ V}$	$V_{GS} = 5.0 \text{ V}$ $I_D = 10 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13 ^b		-	3.5	nC	
Gate-drain charge	Q _{gd}]	see lig. o and 15	-	-	6.0	1	
Turn-on delay time	t _{d(on)}			-	9.3	-		
Rise time	t _r	$V_{DD} = 30 \text{ V}, I_D = 10 \text{ A}$ $R_g = 12 \Omega, R_D = 2.8 \Omega$ see fig. 10 ^b		-	110	-	ns	
Turn-off delay time	t _{d(off)}			-	17	-		
Fall time	t _f			-	26	-		
Internal drain inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- LI	
Internal source inductance	L _S			=	7.5	-	- nH	
Drain-Source Body Diode Characteristic	s	•						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	^	
Pulsed diode forward current ^a	I _{SM}			-	-	40	- A	
Body diode voltage	V _{SD}	T _J = 25 °C, I _S = 10 A, V _{GS} = 0 V ^b		-	-	1.6	V	
Body diode reverse recovery time	t _{rr}	T.=	T _J = 25 °C, I _F = 10 A,		93	130	ns	
Body diode reverse recovery charge	Q _{rr}	$dI/dt = 100 \text{ A/µs}^{b}$		-	0.34	0.65	μC	
Forward turn-on time	t _{on}	Intrinsic tu	n-on is do	minated h	ov Le and	L _D)		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

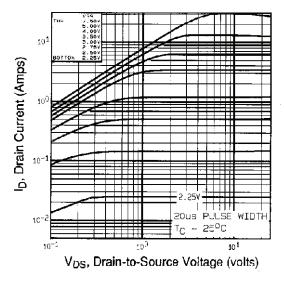


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

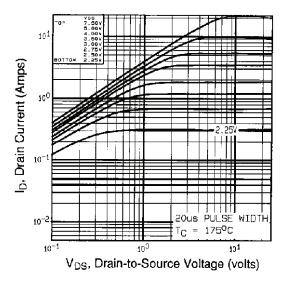


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

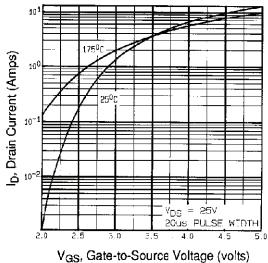


Fig. 3 - Typical Transfer Characteristics

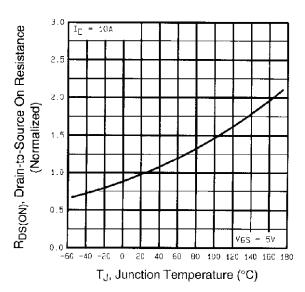


Fig. 4 - Normalized On-Resistance vs. Temperature



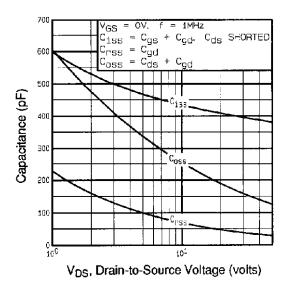


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

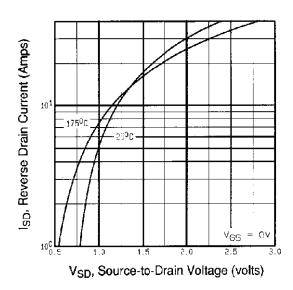


Fig. 7 - Typical Source-Drain Diode Forward Voltage

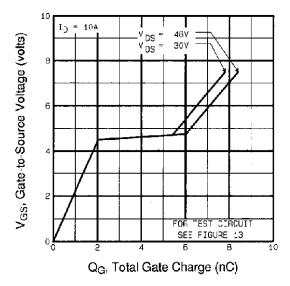


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

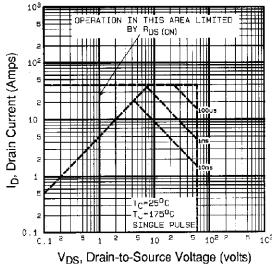


Fig. 8 - Maximum Safe Operating Area





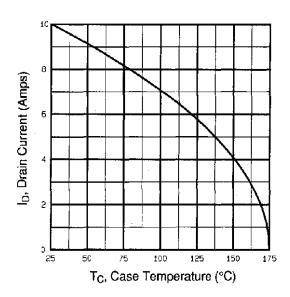


Fig. 9 - Maximum Drain Current vs. Case Temperature

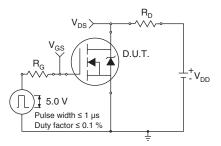


Fig. 10a - Switching Time Test Circuit

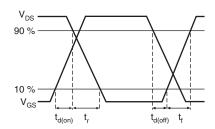


Fig. 10b - Switching Time Waveforms

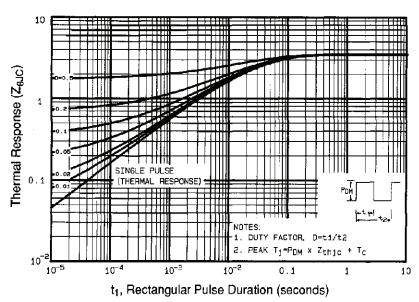


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



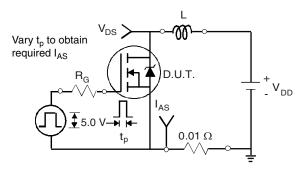


Fig. 12a - Unclamped Inductive Test Circuit

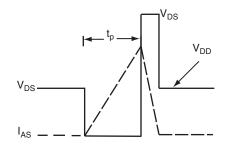


Fig. 12b - Unclamped Inductive Waveforms

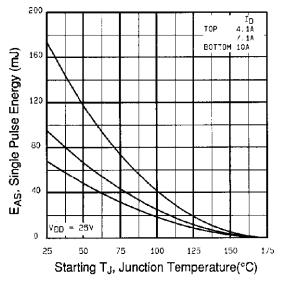


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

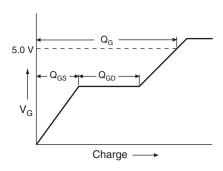


Fig. 13a - Basic Gate Charge Waveform

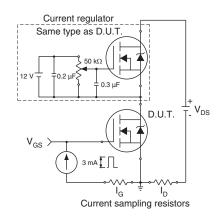
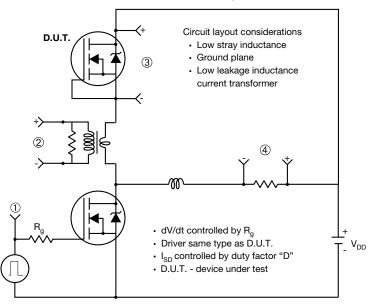


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



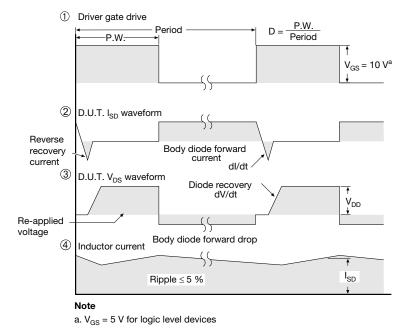


Fig. 14 - For N-Channel

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